Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10526507	HAMAMURA ET AL.
Examiner	Art Unit

1626

SEARCHED					
Class	Subclass	Date	Examiner		

Nolan, Ph.D., Jason M

SEARCH NOTES				
Search Notes	Date	Examiner		
Restriction Requirement (by Nyeemah Grazier)	3/6/2007	NG		
STN Structure Search (Registry/Caplus) - printout attached	5/25/2007	JMN		
IDS Considererd	5/25/2007	JMN		
Specification; Priority Papers; Abstract; Oath reviewed	5/25/2007	JMN		
Inventor Search - reviewed for double patenting	5/25/2007	JMN		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

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